2. Testing and Troubleshooting of Diodes, Zener Diodes and Transistors

Course: ECE1008 – Electronic Hardware Troubleshooting LAB

-Dr Richards Joe Stanislaus

Assistant Professor - SENSE

Email: 51749@vitstudent.ac.in





Aim of the experiment:

- 1) To learn the testing and trouble shooting of Diodes
- 2) To obtain diode characteristics (V-I)
- 3) To learn the testing and trouble shooting of Zener Diodes
- 4) To obtain VI characteristics of Zener Diodes (2 diodes)
- 5) To learn the testing and trouble shooting of Transistors
- 6) To obtain Input and output characteristics of NPN Transistor circuit with
 - a) CE configuration
 - b) CB configuration
 - c) CC configuration



Important NOTE

 Enter your registration number and Full Name next to all your circuits and the output plots.



1. Testing and trouble shooting of Diodes

Black coated: Positive

Silver coated: Negative



1. Testing and trouble shooting of Diodes

Black coated: Positive

Silver coated: Negative





1. Diode: Checks to be performed







1. Diode: Checks to be performed

Damaged diode:
 Opened or Shorted

Open circuit in both directions Opened diode

0 to 0.4V in both directions Shorted diode



2. VI Characteristics of PN junction Diode

Perform the connections as provided in the figure Select the simulation command as DC sweep.

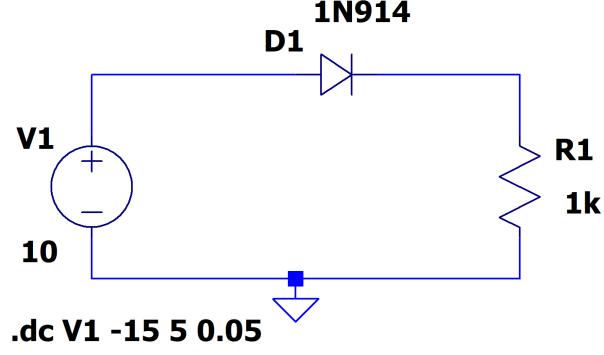
Enter the source "V1" and provide

Start value: -15V

Stop value: 5V

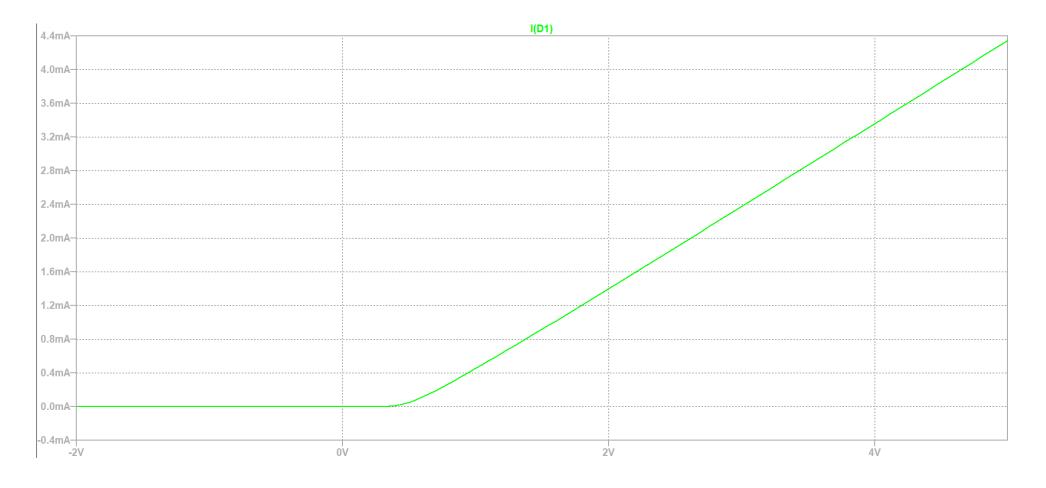
Increment: 0.05

Obtain the diode current: V1 vs ID1



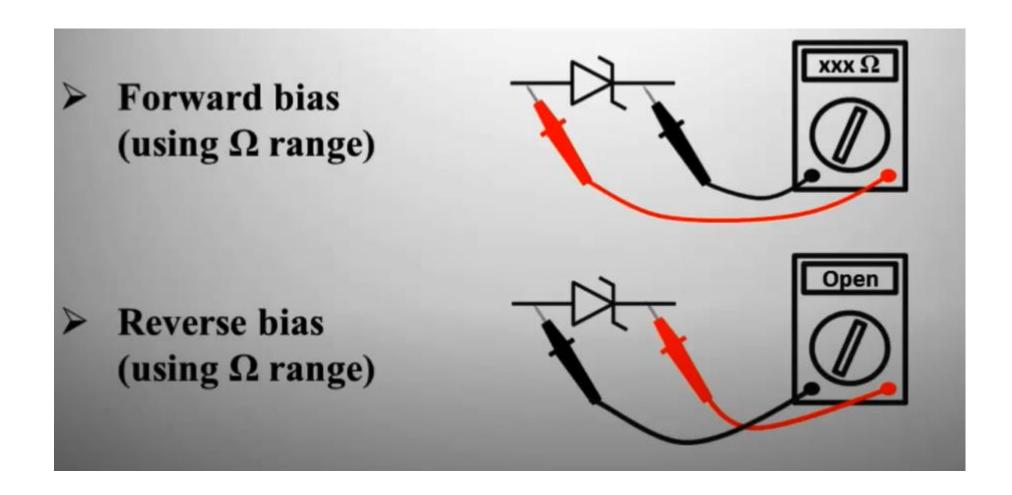


2. VI Characteristics of PN junction Diode





3. 1. Testing and trouble shooting of Zener Diodes: Checks to be performed





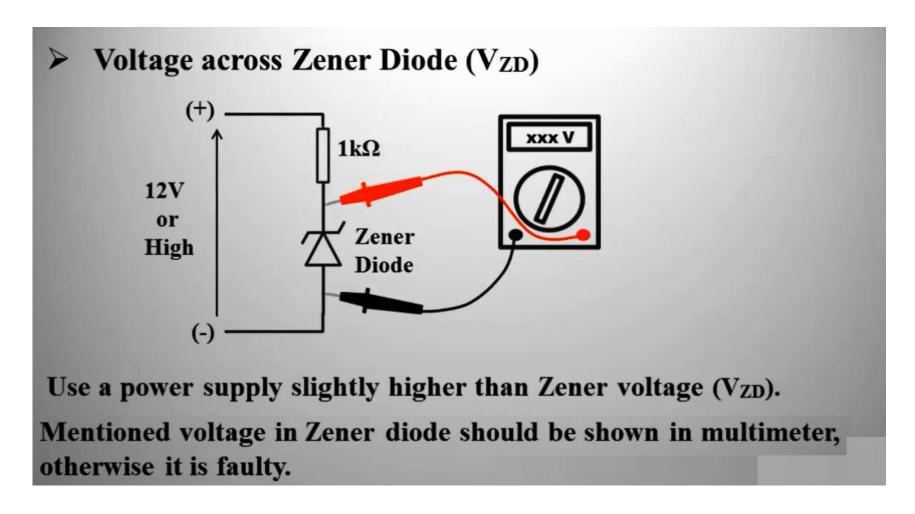
3. 1. Testing and trouble shooting of Zener Diodes: Checks to be performed

Red to Anode(+ve) and Black to Cathode (-ve marked in silver)



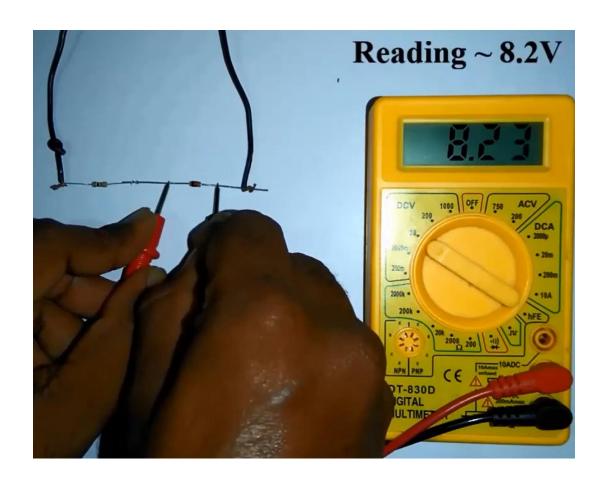


3. 2. Testing and trouble shooting of Zener Diodes: Checks to be performed





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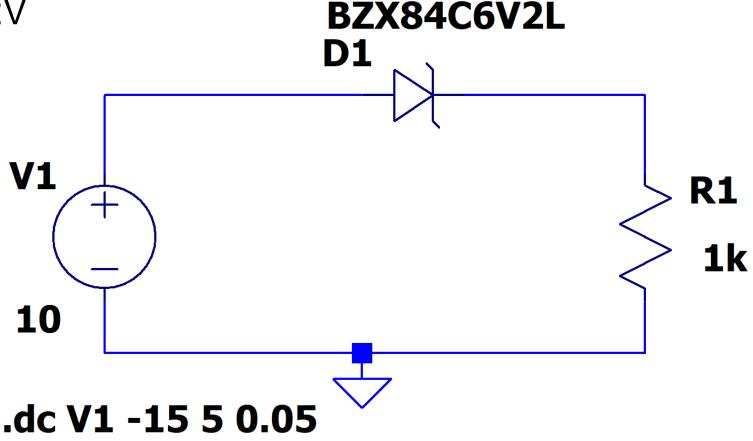




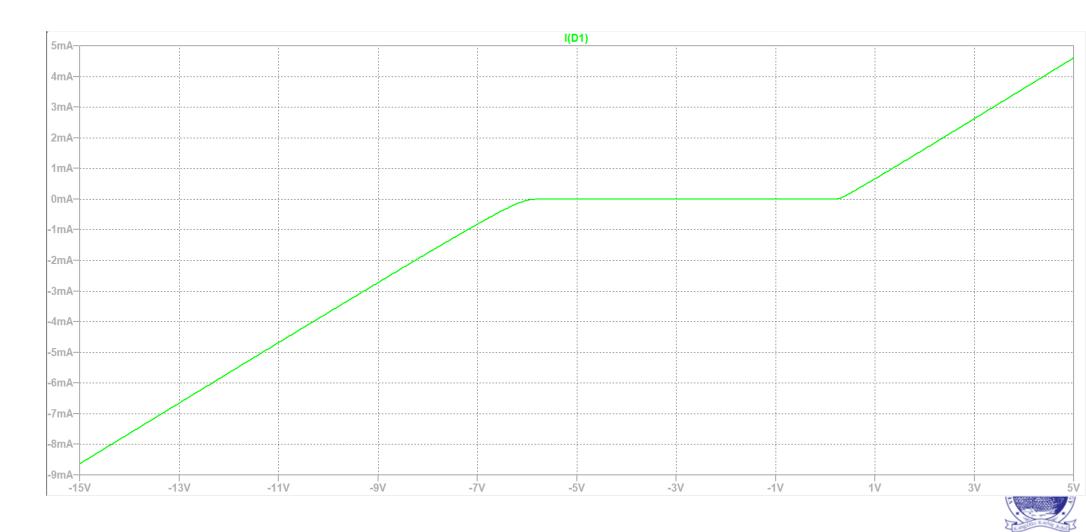
4. VI characteristics of Zener Diode

Zener Diode: BZX84C6V2LD1

Reverse bias voltage: 6.2V

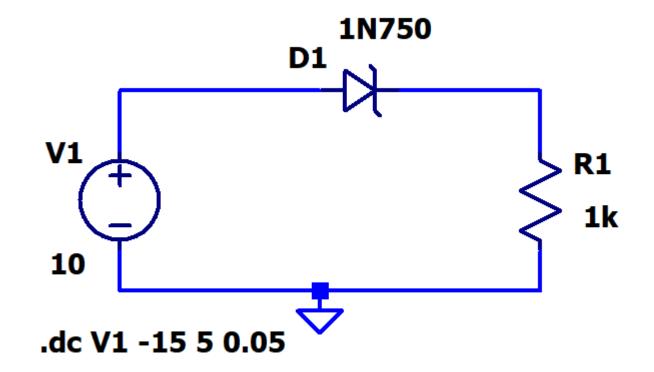


4. VI characteristics of Zener Diode



4. VI characteristics of Zener Diode

- Zener Diode: 1N750
- Voltage vs Current
- V1 vs ID1





5. Troubleshooting of Transistors

- hFE in multimeter: Hybrid
 Forward (current)
 (Common) Emitter
- https://www.youtube.com/watch?v=7u kDKVHnac4
- Current gain (Ic/Ib)



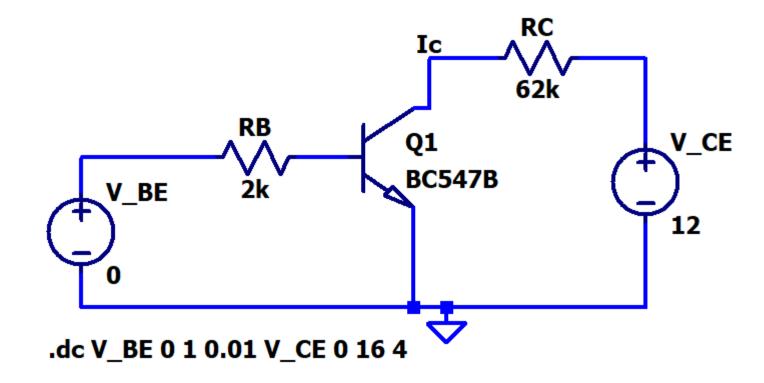
5. Troubleshooting of Tran

- hFE in multimeter: Hybrid
 Forward (current)
 (Common) Emitter
- https://www.youtube.com/watch?v=7u kDKVHnac4
- Current gain (Ic/Ib)



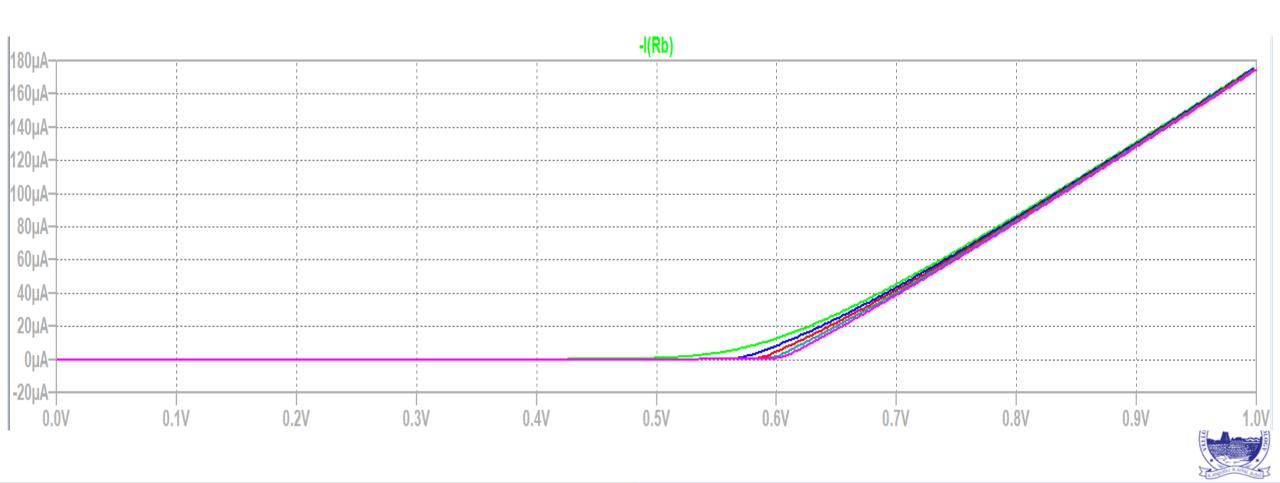


6a -1) Transistor in CE: Input characteristics:

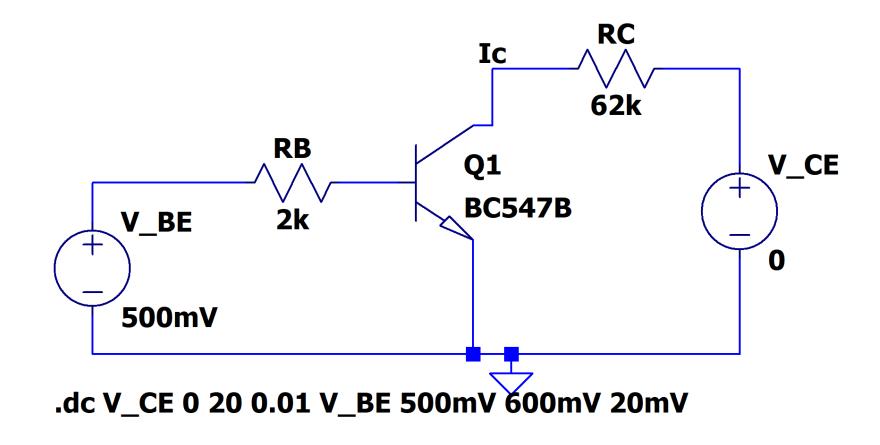




6a -1) Transistor in CE: Input characteristics:

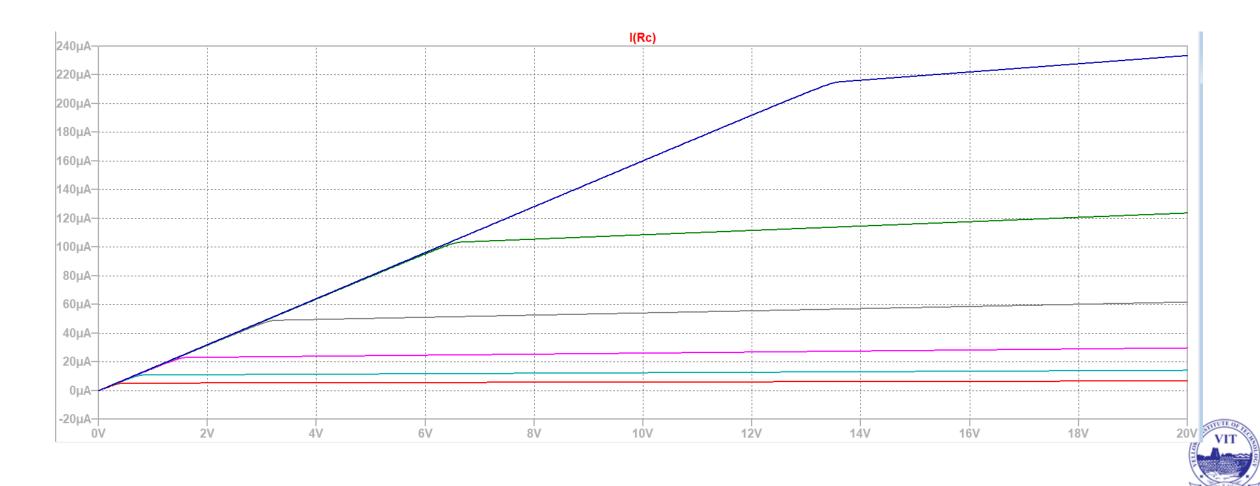


6a-2) CE: Output characteristics:

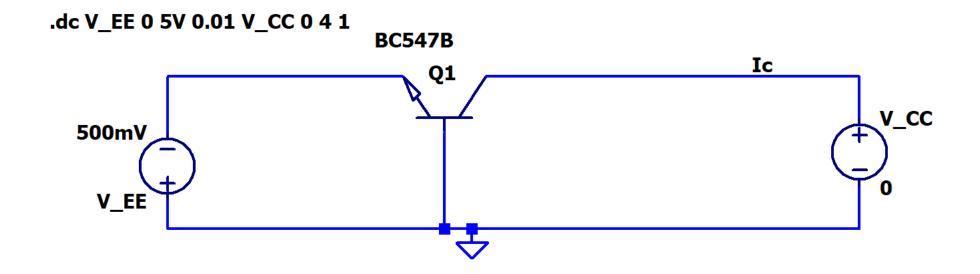




6a-2) CE: Output characteristics:

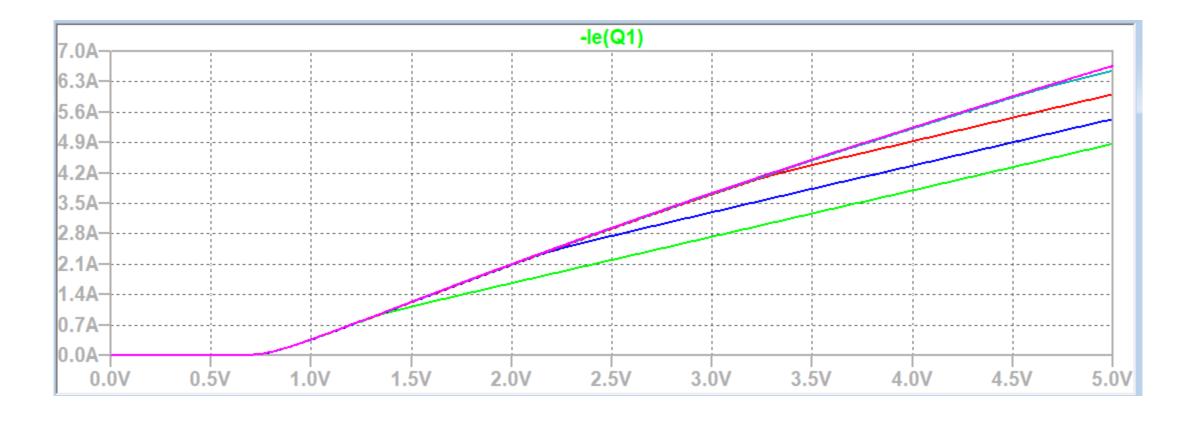


6b-1) CB: Input characteristics:





6b-1) CB: Input characteristics: VEE vs IE

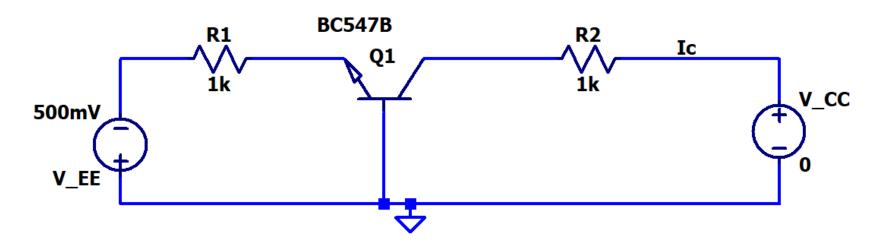




6b-2) CB: Output characteristics:

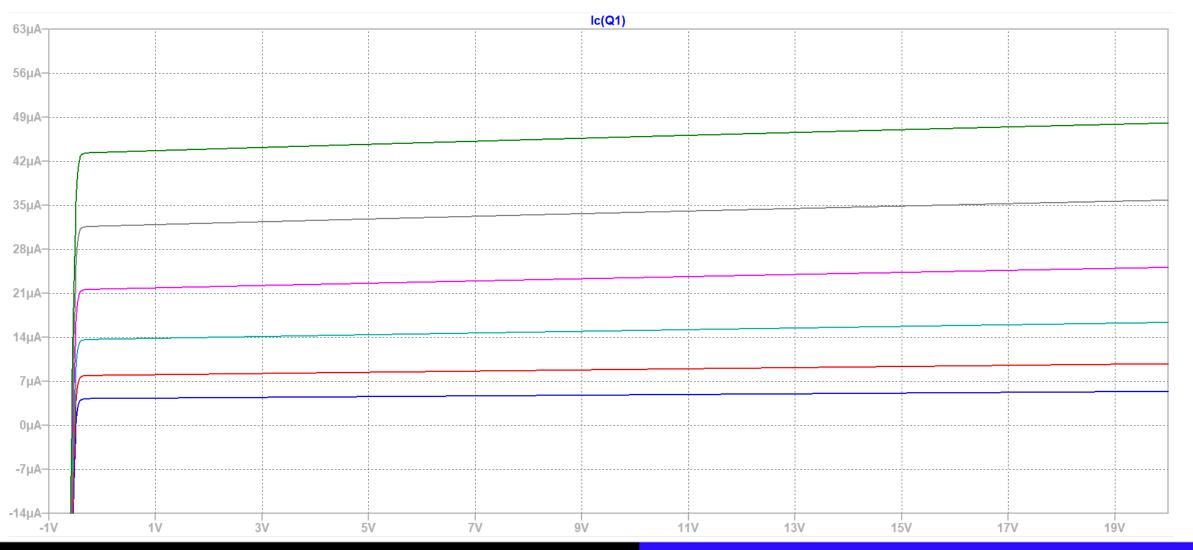
• For different values of input (V_EE), plot V_CC vs IC

.dc V_CC -1 20 0.01 V_EE 500mV 600mV 20mV



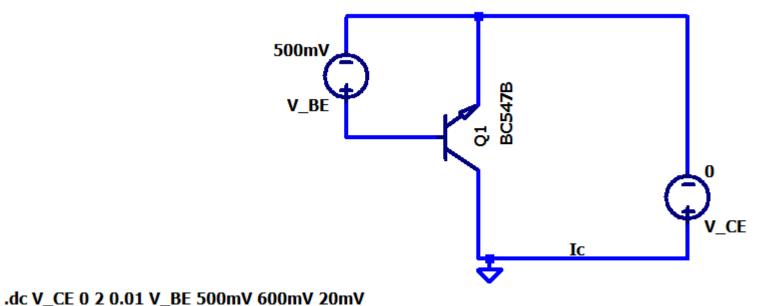


6b-2) CB: Output characteristics: VCC vs IC



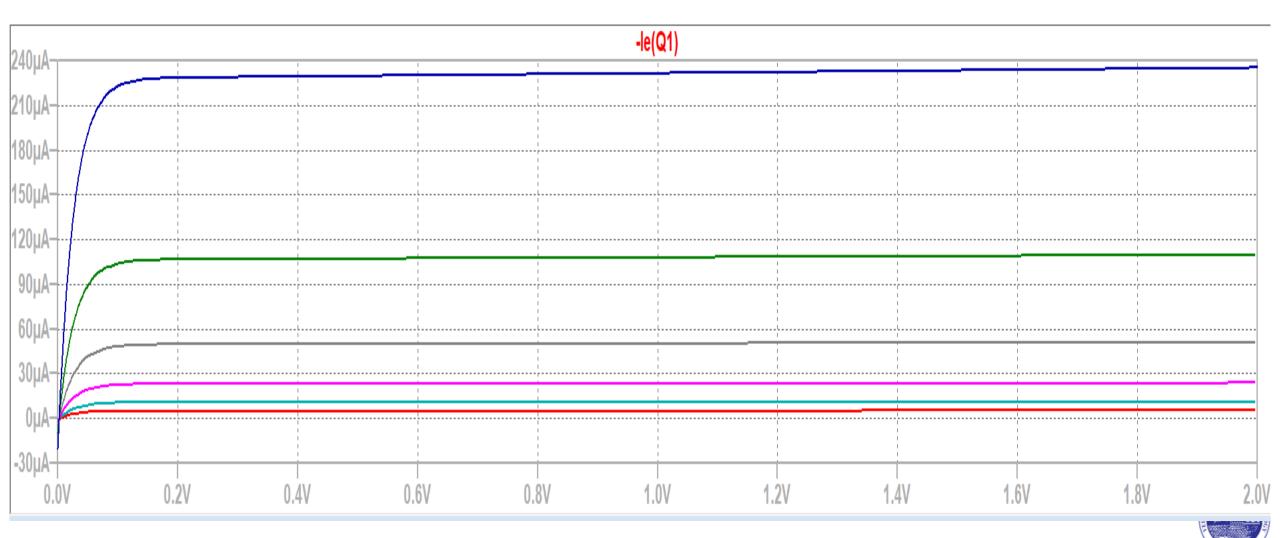


6c-1) CC: Input Characteristics: VBE Vs IE

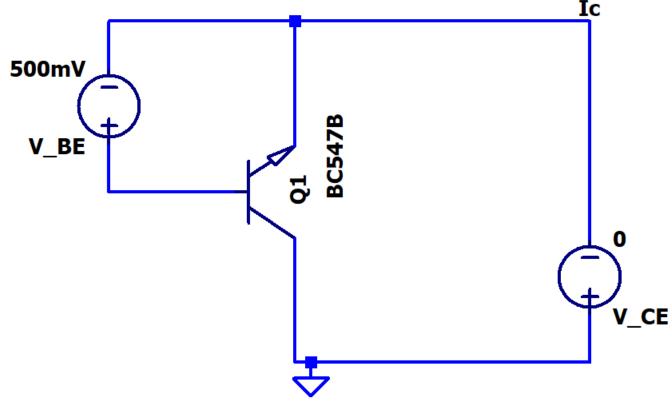




6c-1) CC: Input Characteristics: VBE Vs IE



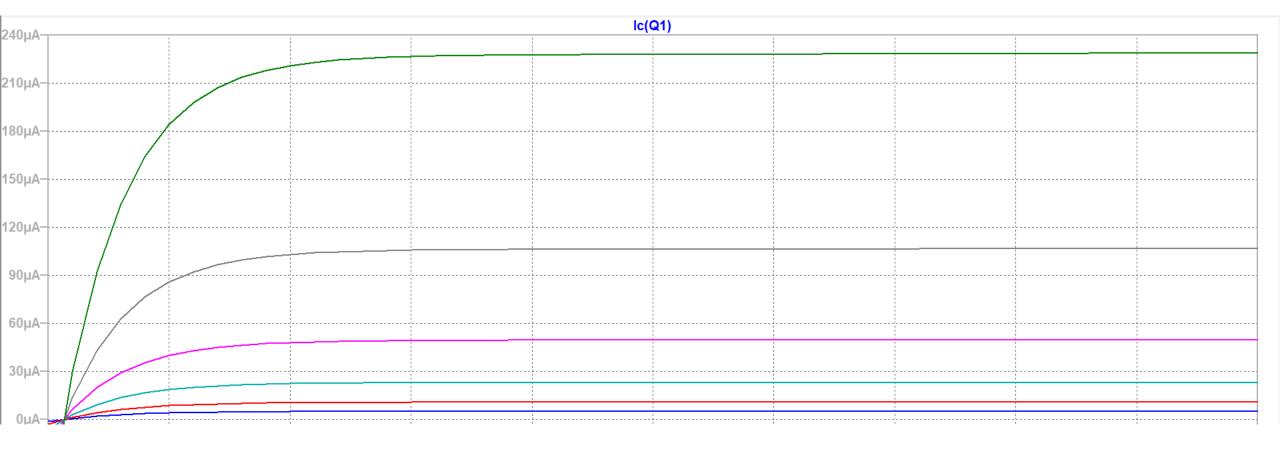
6c-2) CC:Output characteristics: VCE vs IC



.dc V_CE 0 0.5 0.01 V_BE 500mV 600mV 20mV



6c-2) CC:Output characteristics: VCE vs IC





LAB record instructions:

For the lab experiment,

- Write the Aim.
- Complete the Software/Hardware components used.
- Obtain the expression for the outputs.
- Place the respective circuits in LT Spice.
- Connect the inputs and outputs. Name them and write the same in the lab copy(inputs and outputs section).
- Use probe in LT spice to plot all possible combinations.
- Write a concluding statement for each circuit.
- Submit the document's soft copy on time in Ims.vit.ac.in when available.



Sources

- https://www.youtube.com/watch?v=eVnO_bbP8y8
- https://www.youtube.com/watch?v=mx9WWga8xX8

